

# TOSHIBA MOS MEMORY PRODUCT

65,536 WORD X 1 BIT CMOS STATIC RAM  
SILICON GATE CMOS

TC5562P-45  
TC5562P-55

## DESCRIPTION

The TC5562P is a 65,536 bit high speed static random access memory organized as 65,536 words by 1 bit using CMOS technology, and operated from a single 5-volt supply.

Toshiba's high performance device technology provides both high speed and low power features with a maximum access time of 45ns/55ns and maximum operating current of 100mA at minimum cycle time.

The TC5562P also features and automatic stand-

by mode. When deselected by chip Enable( $\overline{CE}$ ), the operating current is reduced from 100mA to 20mA.

The TC5562P is suitable for use in main memory of high speed/high density are required.

The TC5562P is moulded in a 22 pin standard plastic package with 0.3 inch width for high density assembly.

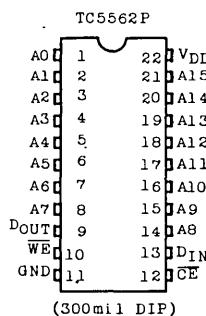
The TC5562P is fabricated with ion implanted COMS silicon gate MOS technology for high performance and high reliability.

## FEATURES

- Fast access time : TC5562P-45 45ns(MAX.)  
TC5562P-55 55ns(MAX.)
- Low power dissipation : Operation 100mA(MAX.)  
Standby 20mA(MAX.)
- 5V single power supply

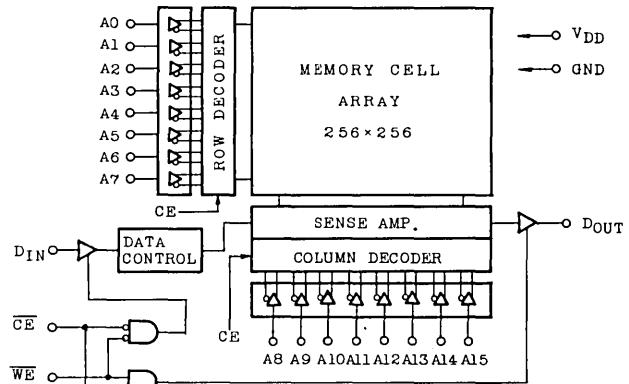
- Fully Static operation
- Directly TTL compatible : All Input and Output
- I/O separate
- Package : 22 pin standard plastic package,  
300mil width

## PIN CONNECTION (TOP VIEW)



(300mil DIP)

## BLOCK DIAGRAM



## PIN NAMES

A0~A15	Address Inputs
DIN	Data Input
Dout	Data Output
$\overline{CE}$	Chip Enable Input
$\overline{WE}$	Write Enable Input
Vdd	Power (+5V)
GND	Ground

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## MAXIMUM RATINGS

SYMBOL	ITEM	RATING	UNIT
$V_{DD}$	Power Supply Voltage	-0.3~7.0	V
$V_{IN}$	Input Voltage	-2.0~7.0	V
$V_{OUT}$	Output Voltage	-0.5~ $V_{DD}+0.5$	V
$P_D$	Power Dissipation	650	mW
$T_{SOLDER}$	Soldering Temperature	260~10	°C·sec
$T_{STG}$	Storage Temperature	-65~150	°C
$T_{OPR}$	Operating Temperature	0~70	°C

## D. C. RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	MIN.	TYP.	MAX.	UNIT
$V_{DD}$	Power Supply Voltage	4.5	5.0	5.5	V
$V_{IH}$	Input High Voltage	2.2	—	$V_{DD}+0.3$	V
$V_{IL}$	Input Low Voltage	-3.0	—	0.8	V

## D. C and OPERATING CHARACTERISTICS (Ta = 0~70°C, V<sub>DD</sub> = 5V ± 10%)

SYMBOL	PARAMETER	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
$I_{IL}$	Input Leakage Current	$V_{IN}=0 \sim V_{DD}$	—	—	±1.0	μA
$I_{OH}$	Output High Current	$V_{OH}=2.4V$	-8	—	—	mA
$I_{OL}$	Output Low Current	$V_{OL}=0.4V$	8	—	—	mA
$I_{LO}$	Output Leakage Current	$\overline{CE}=V_{IH}$ or $\overline{WE}=V_{IL}$ $V_{OUT}=0 \sim V_{DD}$	—	—	±1.0	μA
$I_{DDO}$	Operating Current	$V_{DD}=5.5V$ , tcycle=Min cycle, $\overline{CE}=V_{IL}$ Other Input= $V_{IH}/V_{IL}$	—	—	100	mA
$I_{DDS1}$	Standby Current	$CE=V_{IH}$	—	—	20	mA
$I_{DDS2}$		$CE=V_{DD}-0.2V$ Other Input= $V_{DD}-0.2V$ or 0.2V	—	—	2	

## CAPACITANCE (Ta = 25°C)

SYMBOL	PARAMETER	TEST CONDITION	MAX.	UNIT
$C_{IN}$	Input Capacitance	$V_{IN}=GND$	10	pF
$C_{OUT}$	Output Capacitance	$V_{OUT}=GND$	10	pF

Note : This parameter periodically sampled is not 100% tested.

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## A. C. CHARACTERISTICS (Ta=0~70°C, V<sub>DD</sub>=5V±10%)

### Read Cycle

SYMBOL	PARAMETER	TC5562P-45		TC5562P-55		UNIT
		MIN.	MAX.	MIN.	MAX.	
t <sub>RC</sub>	Read Cycle Time	45	—	55	—	ns
t <sub>AACC</sub>	Address Access Time	—	45	—	55	
t <sub>CO</sub>	Chip Enable Access Time	—	45	—	55	
t <sub>COE</sub>	Chip Enable to Output in Low-Z	5	—	5	—	
t <sub>COD</sub>	Chip Disable to Output in High-Z	—	25	—	30	
t <sub>OH</sub>	Output Data Hold Time	5	—	5	—	

### Write Cycle

SYMBOL	PARAMETER	TC5562P-45		TC5562P-55		UNIT
		MIN.	MAX.	MIN.	MAX.	
t <sub>WC</sub>	Write Cycle Time	45	—	55	—	ns
t <sub>WP</sub>	Write Pulse Width	30	—	35	—	
t <sub>CW</sub>	Chip Enable to End of Write	30	—	35	—	
t <sub>AS</sub>	Address Set up Time	0	—	0	—	
t <sub>WR</sub>	Write Recovery Time	0	—	0	—	
t <sub>OEW</sub>	WE to Output Low-Z	0	—	0	—	
t <sub>OEW</sub>	WE to Output High-Z	—	25	—	30	
t <sub>DS</sub>	Data Set up Time	30	—	35	—	
t <sub>DH</sub>	Data Hold Time	0	—	0	—	

### A. C. TEST CONDITIONS

Input Pulse Levels	2.4V/0.6V
Input Rise and Fall Times	5ns
Input and Output Timing Reference Levels	1.5V
Output Load	See Fig.1

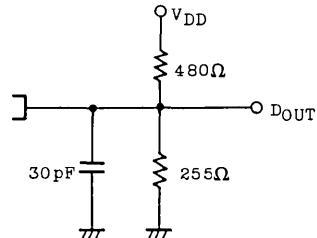


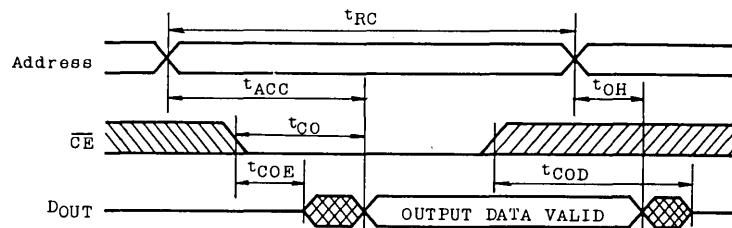
Fig.1 Output Load

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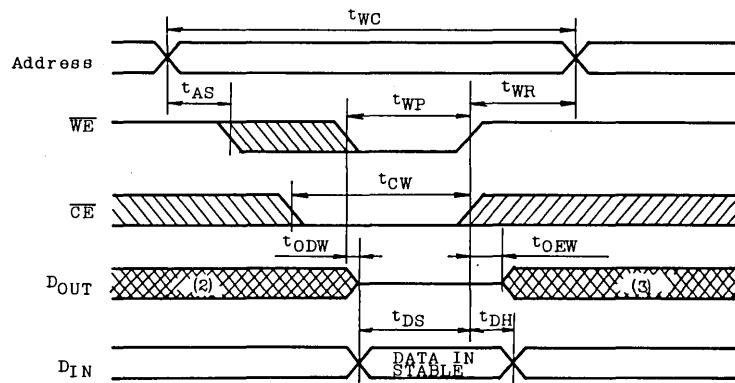
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## TIMING WAVEFORMS

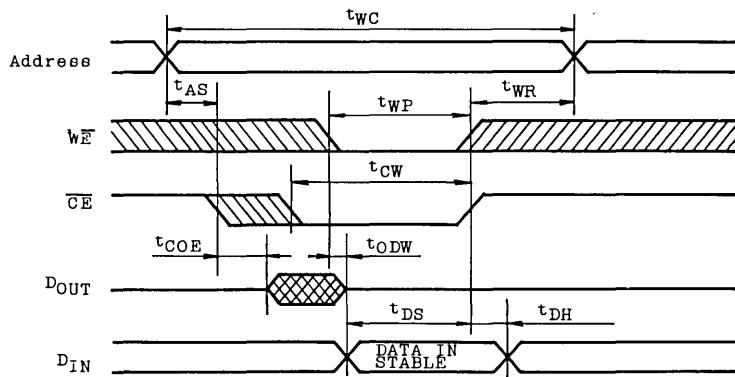
- READ CYCLE (1)



- WRITE CYCLE 1 ( $\overline{WE}$  Controlled Write)



- WRITE CYCLE 2 ( $\overline{CE}$  Controlled Write)

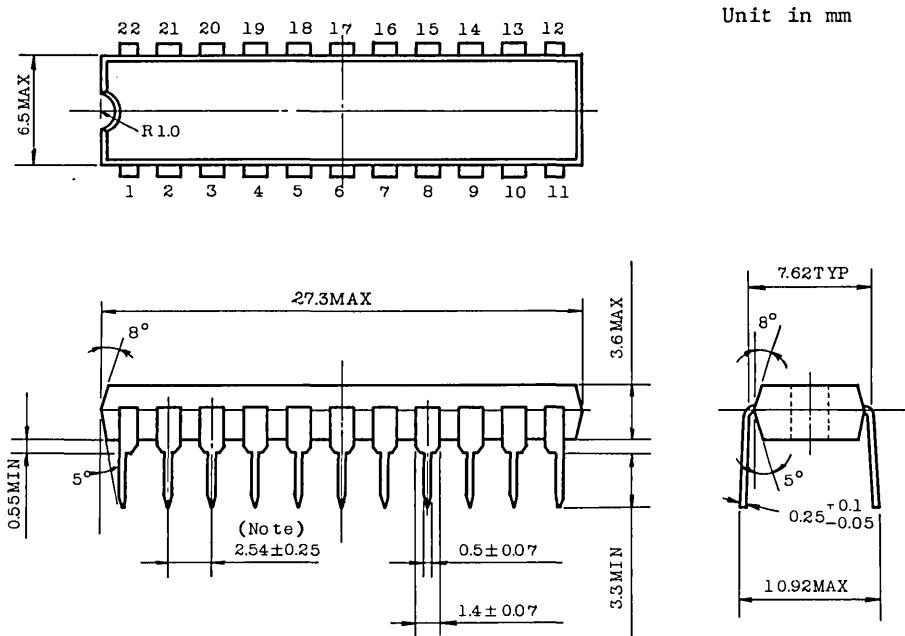


Note :

1.  $\overline{WE}$  is High for Read Cycle.
2. Assuming that  $\overline{CE}$  Low transition occurs coincident with or after  $\overline{WE}$  Low transition, Outputs remain in a high impedance state.
3. Assuming that  $\overline{CE}$  High transition occurs coincident with or prior  $\overline{WE}$  High transition, Outputs remain in a high impedance state.
4. The operating temperature( $T_a$ ) is guaranteed with transverse air flow exceeding 400 linear feet per minute.

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**OUTLINE DRAWINGS**



Note : Each lead pitch is 2.54mm.

All leads are located within 0.25mm of the true longitudinal position with respect to No.1 and No.22 leads.